

Notice of References Cited	Application/Control No. 10/698,425	Applicant(s)/Patent Under Reexamination CHA ET AL.	
	Examiner Anne M. Hines	Art Unit 2879	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,559,592	05-2003	Lee, Yoon Kwan	313/495
	B	US-6,469,440	10-2002	Saito et al.	313/582
	C	US-2004/0232813	11-2004	Nakano et al.	313/112
	D	US-2004/0027514	02-2004	Kobayashi et al.	349/110
	E	US-6,197,408	03-2001	Kanbara et al.	428/209
	F	US-4,958,148	09-1990	Olson, Jan B.	345/174
	G	US-4,514,585	04-1985	Paynton, Richard D.	174/35GC
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.